Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/604,541	CHANG, YI-HUI
Examiner	Art Unit
James W. Cranson	2875

SEARCHED			
Class	Subclass	Date	Examiner
362	31	1/29/2005	JWC
362	26	1/29/2005	JWC
362	561	1/29/2005	JWC
349	65	1/29/2005	JWC
362	555	1/29/2005	JWC

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
362/\$	1/29/200	5 JWC
349/\$	1/29/200	5 JWC
315/\$	1/29/200	5 JWC